MOSFET – Power, Single N-Channel 40 V, 7.3 m Ω , 54 A

NVTYS007N04CL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	40	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	54	Α
Current R _{0JC} (Notes 1, 2, 3, 4)	Steady State	T _C = 100°C		38	
Power Dissipation		T _C = 25°C	P_{D}	38	W
R _{θJC} (Notes 1, 2, 3)		T _C = 100°C		19	
Continuous Drain		T _A = 25°C	I _D	16	Α
Current R _{θJA} (Notes 1, 3, 4)	Steady State	T _A = 100°C		11	
Power Dissipation		T _A = 25°C	P_{D}	3.1	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		1.5	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	215	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	31.3	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 3 A)			E _{AS}	66	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	4.0	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	48	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

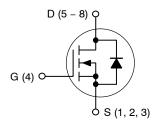


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
40 V	7.3 mΩ @ 10 V	54 A	
40 V	12 mΩ @ 4.5 V	34 A	

N-Channel





LFPAK8 3.3x3.3 CASE 760AD

MARKING DIAGRAM

007N 04CL AWLYW

007N04CL = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

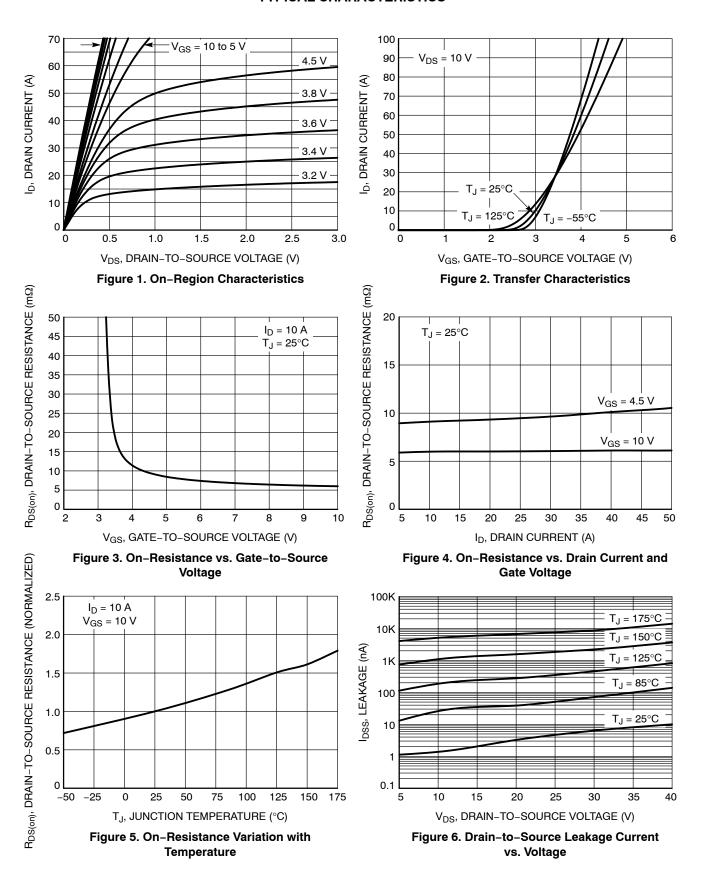
OFF CHARACTERISTICS Drain-to-Source Breakdown Voltage Drain-to-Source Breakdown	1	•					
	Ι						
Drain-to-Source Breakdown	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Voltage Temperature Coefficient	V _{(BR)DSS} /				19		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{CS} = 0 \text{ V}$ $T_J = 25^{\circ}\text{C}$				10	μΑ
		$V_{GS} = 0 V$, $V_{DS} = 40 V$	T _J = 125°C			250	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{G}$	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 30 μΑ	1.2		2.2	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _E	₀ = 10 A		6.1	7.3	mΩ
		V _{GS} = 4.5 V, I	_D = 10 A		9.3	12	1
Forward Transconductance	9FS	V _{DS} = 5 V, I _D	= 25 A		55		S
CHARGES AND CAPACITANCES	•					•	•
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 25 \text{ V}$			900		pF
Output Capacitance	C _{oss}				340		
Reverse Transfer Capacitance	C _{rss}				15		
Total Gate Charge	Q _{G(TOT)}				7.8		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 32 \text{ V}, I_D = 25 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 32 \text{ V}, I_D = 25 \text{ A}$			1.5		nC
Gate-to-Source Charge	Q _{GS}				2.7		1
Gate-to-Drain Charge	Q_{GD}				2.7		1
Total Gate Charge	Q _{G(TOT)}				16		nC
SWITCHING CHARACTERISTICS (N	lote 6)					•	•
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{D}$	ne = 32 V.		13		1
Turn-Off Delay Time	t _{d(off)}	$I_D = 25 \text{ A}, R_G = 2.5 \Omega$			16		1
Fall Time	t _f				6		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS	•	•		•	•	•
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V$,	T _J = 25°C		0.9	1.2	V
		I _S = 25 A	T _J = 125°C		0.8		7
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dl_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $l_{S} = 25 \text{ A}$			26		ns
Charge Time	ta				12		1
Discharge Time	t _b				14		1
Reverse Recovery Charge	Q _{RR}				10		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

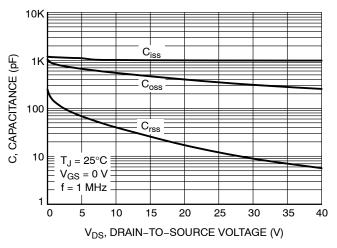


Figure 7. Capacitance Variation

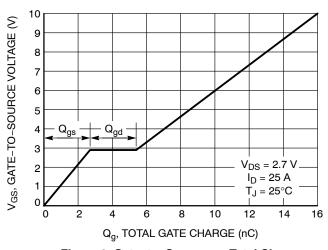


Figure 8. Gate-to-Source vs. Total Charge

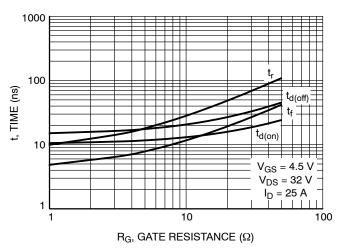


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

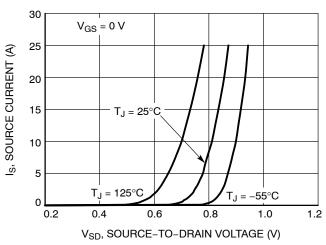


Figure 10. Diode Forward Voltage vs. Current

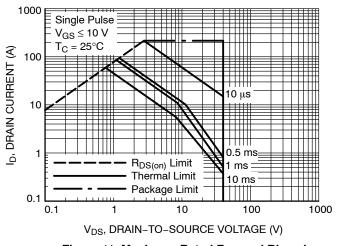


Figure 11. Maximum Rated Forward Biased Safe Operating Area

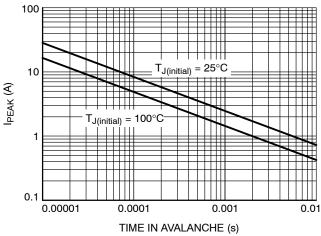


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

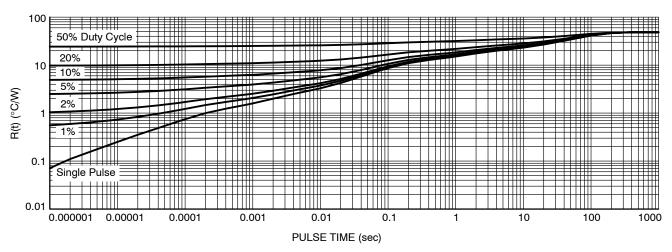


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

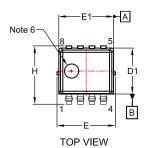
Device	Marking	Package	Shipping [†]
NVTYS007N04CLTWG	007N 04CL	LFPAK33 (Pb-Free)	3000 / Tape & Reel

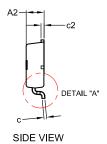
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

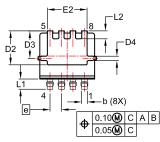
PACKAGE DIMENSIONS

LFPAK8 3.3x3.3, 0.65P

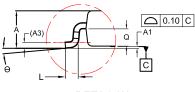
CASE 760AD **ISSUE E**



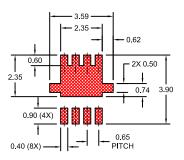












LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 1994.
- CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS OR BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- 6. OPTIONAL MOLD FEATURE.

DIM	MILLIMETERS			
Diw	MIN.	NOM.	MAX.	
Α	0.95	1.05	1.15	
A1	0.00	0.05	0.10	
A2	0.95	1.00	1.05	
A3		0.15 REI	F	
b	0.27	0.32	0.37	
С	0.12	0.17	0.22	
c2	0.12	0.17	0.22	
D1	2.50	2.60	2.70	
D2	1.82	1.92	2.02	
D3	1.46	1.56	1.66	
D4	0.20	0.25	0.30	
Е	3.20	3.30	3.40	
E1	3.00	3.10	3.20	
E2	2.15	2.25	2.35	
е	0.65 BSC			
I	3.20	3.30	3.40	
L	0.25	0.37	0.50	
L1	0.48	0.58	0.68	
L2	0.35	0.45	0.55	
Q	0.45	0.50	0.55	
θ	0°	4°	8°	
0	U	-		

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